

**Notice of References Cited**

Application/Control No.

10/035,637

Applicant(s)/Patent Under  
Reexamination  
DEO ET AL.

Examiner

G. R. Ewoldt, Ph.D.

Art Unit

1644

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Kobayashi et al., Prot. Eng. 1999, 12(10):879-884 ✓			
	V	Tuting et al., J. Immunol. 1998, 160:1139-1147 ✓			
	W	Geissmann et al., J. Immunol. 2001, 166:346-352 ✓			
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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